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Application/Control No.	Applicant(s)/Patent under Reexamination
10/605,448	BEYER ET AL.
Examiner	Art Unit
Dennis Myint	2162

SEARCHED				
Class	Subclass	Date	Examiner	
707	100	8/22/2006	DM	
707	1	8/23/2006	DM	
705	1	1/26/2007	DM	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST (EPO; JPO; IBM; USPAT)	8/22/2006	DM
EAST (EPO; JPO; IBM; USPAT)	8/23/2006	DM
- NPL: ACM	8/22/2006	DM
EAST (EPO; JPO; IBM; USPAT; USPGPUB)	1/26/2007	DM